


<b>Search Notes</b>  	<b>Application/Control No.</b>  10528928	<b>Applicant(s)/Patent Under Reexamination</b>  MERCKEN ET AL.
	<b>Examiner</b>  Wang, Chang-Yu	<b>Art Unit</b>  1649

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST, STN: search strategy attached (updated)	8/31/09	CYW
Inventor name search: EAST, STN, PALM (updated)	8/31/09	CYW
Sequence search: oligomer search on SEQ ID NOS: 1-4. See search results in SCORE.	8/31/09	CYW
PLUS search from STIC. See search results in eDAN (8/31/09).	8/31/09	CYW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/C. Y. W./  
Examiner, Art Unit 1649